

# Audio Analyzer UPL

# The solution for the budget-conscious

- For all interfaces: analog, digital and combined
- Real dual-channel measurements
- Maximum dynamic range
- FFT analysis
- Jitter analysis
- Interface tester
- Freely programmable filters
- Versatile functions
- Compact unit with integrated PC
- Automatic test sequences
- Extensive online help



# Audio analysis today and tomorrow

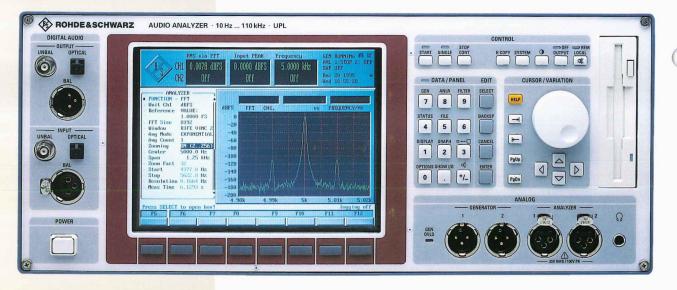
# Analog and digital

Audio signal processing is nowadays no longer conceivable without the use of digital techniques. Yet, analog technology continues to exist and undergoes constant improvement. Stateof-the-art measuring instruments must therefore be able to handle both analog and digital signal processing. The generator is every bit as versatile: it supplies any conceivable signal from sinewave and noise signals through to multi-sinewave signals comprising up to 7400 frequencies.

In addition to all this, UPL features excellent technical data: analog sinewave generation with harmonics of

# Superior analysis concept

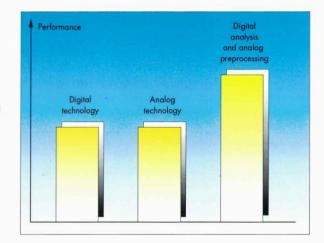
UPL performs all measurements using digital signal processing. Analog signals to be tested undergo elaborate preprocessing before they are digitized and measured by means of digital routines. For example, in THD measurements, the fundamental wave is attenu-



Audio Analyzer UPL performs practically all types of analog measurement, from frequency response measurements through to externally controlled sweeps with reference traces, determination of 3rd-order difference frequency distortion, spectral display of demodulated wow and flutter signals, etc. In contrast to many other audio analyzers, UPL is capable of performing real dual-channel measurements in the audio-frequency range, ie there is no need for switchover between two inputs and this facility is not limited to a few special cases. typ. –115 dB, spectrum displays with a noise floor below –140 dB for analog and –160 dB for digital interfaces, FFT with a maximum frequency resolution of 0.05 Hz, etc.

UPL provides signal monitoring via loudspeaker during the test, jitter measurements on digital audio signals, resynchronization of jittered digital audio signals by means of a jitter-free clock signal, and many more features. ated by means of a notch filter and the residual signal amplified by 30 dB before it is digitized. In this way, the dynamic range can be extended beyond that offered by the internal 20-bit converter. This provides the scope required for measuring future converters, which will be technically more advanced than present-day devices (see graph on the right). This concept guarantees a performance and flexibility by far superior to instruments providing purely analog or digital measurements. The above measurement concept offers many more advantages over merely analog concepts:

- The test routines performed on analog and digital interfaces are identical. This allows, for instance, the direct comparison of IMD measurements made ahead of and after a converter.
- In intermodulation measurements, spurious components are measured selectively for all frequencies in accordance with the mathematical formula of the relevant test standards. This procedure avoids the measurement of adjacent components along with the spuria, which is usually inevitable with analog test methods.



- All test functions are available both on the analog and the digital interfaces. This makes it possible to measure at any point of a common analog and digital transmission path. Only this ensures efficient and complete testing.
- The filters, too, were implemented digitally, resulting in an infinite number of filters as it were, and this also for measurements on analog interfaces. Just choose the type of filter (eg highpass), cutoff frequency and attenuation: that's all you have to do to loop a new filter into the test path.
- Measurement speed is as a rule higher than with analog techniques since digital test routines can adapt their speed to the input frequency. And – last but not least:

tions

The intelligent combination of analog and

digital measurement

techniques paves the

way for future applica-

 Operation is the same for the analog and the digital interfaces. A feature that should not be underestimated.

## A future-proof investment

Nobody can accurately predict today what effects future developments in digital technology will have on the audio world and what will be the resulting test requirements. This is however no problem for Audio Analyzer UPL. Since all test functions are implemented digitally, UPL can be adapted to changing requirements by simply loading the necessary software – and this also for the analog interfaces.

And one more thing: Rohde & Schwarz is the only manufacturer to equip its audio analyzers with 32-bit floating-point signal processors throughout, thus offering plenty of reserves beyond the limits of today's common 24-bit technology.

## A competent partner

The name of Rohde & Schwarz stands for excellent quality – thousands of audio analyzers have proven records at satisfied customers and have been in operation successfully for many years. After the purely analog UPA and UPD, which still holds the top position in today's audio measurement technology, Audio Analyzer UPL has been developed to complete the program.

As a competent partner we shall be pleased to advise you on the optimum use of our instruments. Our representatives are available for you all over the world, and our customer support center and application engineers in Munich are there to help you find the right solution to your measurement tasks. In addition, you will find a wealth of proposals and solutions in our application notes and software.

Naturally, Rohde & Schwarz instruments are certified in compliance with ISO 9001.



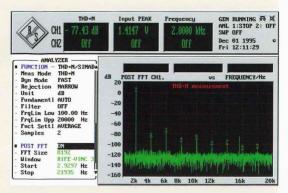


Fig. 1: Automatic marking of harmonics in THD+N measurements makes nonharmonics visible at a glance

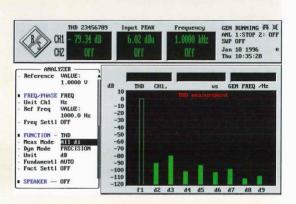


Fig. 2: In THD measurements, single harmonics, all harmonics or any combination of harmonics can be measured

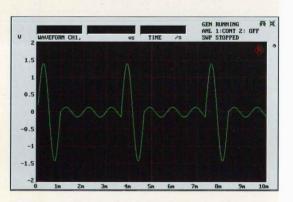


Fig. 3: The waveform function displays the test signal in the time domain. The example shows a sinewave burst

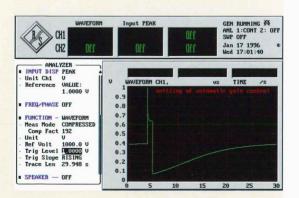


Fig. 4: The transient characteristics of an AGC play an important role in testing hearing aids or automatic volume control on tape recorders

# Versatile test functions

UPL offers a wealth of measurement functions both for analog and – with option UPL-B2 – digital interfaces.

## • Level or S/N

with rms, peak or quasi-peak weighting

Selective level

The center frequency of the bandpass filter can be swept or coupled to the generator frequency, to the frequencies of a multitone signal (eg for fast frequency response measurements) or to the input signal.

- SINAD or (THD+N) The sum of all harmonics and noise is measured (Fig. 1).
   Table provide the state of the stat
- Total harmonic distortion (THD) Single harmonics, all the harmonics or any combination of harmonics can be measured (Fig. 2).
- Modulation distortion to DIN-IEC 268-3. 2nd and 3rd order intermodulation is measured.
- Intermodulation
   using the difference tone method.
   2nd and 3rd order intermodulation
   is measured.
- Wow and flutter

to DIN IEC, NAB, JIS or the 2-sigma method to DIN IEC where the demodulated-signal spectrum is also displayed.

• Polarity test

for checking signal paths for reversed polarity.

- Crosstalk
- Waveform function

for representing the test signal in the time domain (Fig. 3). Waveforms can be smoothed by interpolation. Slow sequences can be displayed compressed, eg for analyzing the transient response of compander or AGC circuits (Fig. 4).

# An allrounder



- DC voltage
- Frequency, phase and group delay

# Test signals – as you like it

The generators of UPL supply an extremely wide variety of analog and – with option UPL-B2 – digital test signals:

## Sinewaves

for level and harmonic distortion measurements. The signal can be applied to an equalizer with user-selectable nominal frequency response, eg for compensating the frequency response of the test assembly.

Two-tone signal

for modulation distortion analysis. Various amplitude ratios can be selected and the frequencies are continuously adjustable.

Difference tone signal

for intermodulation measurements with continuous setting of the center frequency and frequency difference.



## Multitone signal

comprising up to 17 sinewaves of any frequency and with the same or different levels.

Special multitone signal

comprising up to 7400 frequencies with selectable amplitude distribution. The frequency spacing can be linked to the resolution used for the Fast Fourier Transform, thus enabling rapid and precise single-shot measurements of the frequency response of a DUT.

• Sine burst signal

with adjustable interval and on-time and programmable low level, eg for testing AGCs.

## • Sine<sup>2</sup> burst

also with adjustable interval and on-time, eg for testing rms rectifier circuits.

Noise

with a variety of probability distributions, eg for acoustic measurements.

• Arbitrary waveforms for generating any voltage curve of up to 16k points.

Signals can be measured with an offset, digital audio signals can be dithered with adjustable level, and selectable amplitude distribution can be added to digital audio signals.

Tests on hi-fi components call for increasingly complex measurement techniques. Results obtained in the test lab must be verified in production, where as a rule not the whole range of test functions is needed but economical solutions to cater for large batches. UPL is an ideal choice for this task, and it optimally complements its "bigger brother", Audio Analyzer UPD, which is mainly employed in development. The operating concept of the two units based on the same IEC/IEEE-bus commands is identical, so there is no problem using them jointly.

# A variety of sweep functions

For continuous variation of the test signals, UPL offers amplitude and frequency sweeps and for bursts additionally sweeps of the interval and the on-time. Sweeps are defined either by means of a table or via parameters such as start value, number of steps, linear/ log stepping or time interval. It is also possible to sweep two variables simultaneously.

In measurements of external signals, these can be used for analyzer sweeps (external sweeps). Many different start conditions can be set, allowing measurements to be triggered by a variety of events. Results will be stable even for DUTs with unknown or unstable transient response thanks to the settling function.



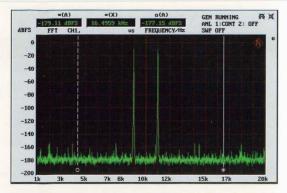


Fig. 5: FFT spectrum of two-tone signal shown on full screen

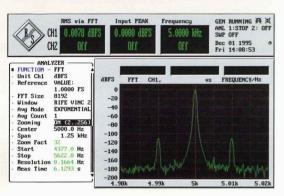


Fig. 6: With the zoom FFT function, sidebands spaced only a few hertz from the signal can be displayed

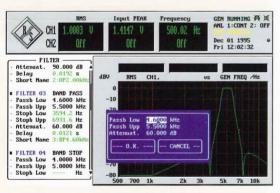


Fig. 7: Filters can be defined by entering just a few parameters

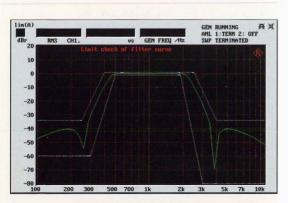


Fig. 8: Tolerance curves enable fast go/nogo tests

## Spectral analysis

With its FFT analyzer, UPL is also capable of spectrum analysis. The number of samples for Fast Fourier Transform can be selected between 256 and 16k in binary steps (Fig. 5). A special feature is zoom FFT. The signal to be measured is digitally preprocessed to increase the frequency resolution by a factor of 2 to 128 over a selectable range. In this way, a maximum resolution of 0.05 Hz is attained. It should be emphasized that this is not just a scale expansion but the measurement is really made at a higher resolution (Fig. 6).

# **Programmable filters**

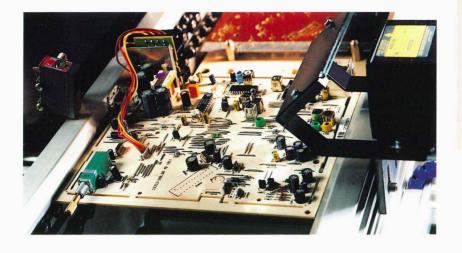
The filters of UPL are software-implemented so that the user can define any number of filters. The most common weighting filters are provided as standard. Further filters can be programmed in a few seconds by entering the type (lowpass, highpass, bandpass, bandstop, notch, third octave or octave), frequency and attenuation (Fig. 7). The instrument's open architecture shows its strength in particular where special requirements have to be met: special filters can be implemented using commercial filter design programs. The data are transferred to UPL and the designed filter looped into the signal path.

# Fast and efficient

## High measurement speed

In designing Audio Analyzer UPL, particular emphasis was placed on optimizing the measurement speed of the test system as a whole:

- All operations involving elaborate computing are carried out by digital signal processors. The PC is merely used for control of the unit and display of results.
- UPL can perform even complex test functions simultaneously on both channels. This feature alone reduces the time for stereo measurements by 50% compared with most analyzers available on the market.
- The digital test routines adapt their speed optimally to the input frequency. This enhances measurement speed especially in the case of frequency sweeps.
- UPL performs harmonic distortion and IMD measurements using patented, digital test procedures that combine high accuracy with high measurement speed.
- Digital signal processing even reduces setting and transient times achievable with purely analog instruments. These times are also taken into account in the test routines, yielding stable measurements without the need for activating settling functions (these are understood to be repeated measurements until results are within a tolerance band).
- The user interface was tailored to the requirements of a test, not of an office environment.



High measurement speed, two-channel measurements and remote-control capability via the IEC/IEEE bus are a must in production systems. The long calibration intervals of UPL make for high availability and reduce running costs.

 Any display panels not needed can be switched off, which also cuts down the processing time. When all displays are switched off and results are output via the IEC/IEEE bus, more than 100 level measurements per second can be made.

# Use in production

Instruments to be used in production tests must satisfy a variety of requirements:

- High measurement speed is vital for achieving a high production throughput. By making appropriate use of the instrument functions, go/nogo decisions can be made already in the audio analyzer, thus reducing the run time of a DUT (Fig. 8).
- Two-channel measurements allow the simultaneous and thus time-saving determination of input and output characteristics.

- The use of FFT analysis provides a decisive advantage especially in the case of frequency response measurements, which are particularly time-critical. Example: 900 frequency values in 150 ms.
- The built-in monitor allows manual operation of UPL also in system applications, enabling fast fault localization in the event of production problems.
- Long calibration intervals, resulting from the extensive use of digital circuits, make for high availability of the instrument.
- Remote-control capability via the IEC/IEEE bus is a must in large-scale production systems. In the design of Audio Analyzer UPL, special importance was attached to data transfer via the IEC/IEEE bus. The logging mode can be used to speed up the generation of control programs for the IEC/IEEE bus. With the program generator provided in UPL-B10, it is no longer necessary to look up IEC/IEEE-bus commands.



Special tests are required in the development and production of hearing aids. No problem for UPL.

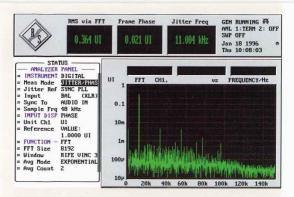


Fig. 9: Individual interference components can easily be found with the aid of the jitter spectrum.

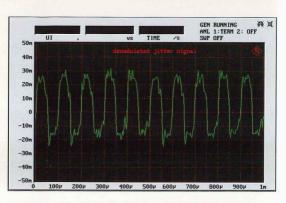


Fig. 10: Display of jitter signal in time domain

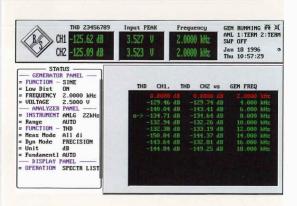


Fig. 11: Complete measured-value tables can be output for all functions



Fig. 12: UPL generates and analyzes additional data in digital data streams in line with all common standards. The data are represented in binary form, as hexadecimal numbers, as ASCII characters or evaluated in consumer or professional format

# Interfaces, protocol analysis, jitter

## Analog interfaces

- Balanced inputs with high common-mode rejection and various impedances commonly used in the studio. Measurements can be made on lines with phantom feed.
- Balanced outputs, floating (to prevent hum loops).
- The generator outputs can be internally connected to the analyzer inputs so that different types of measurement can be made without the need for changing the cabling.

## Digital audio interfaces (option UPL-B2)

- Balanced (XLR), unbalanced (BNC) and optical (TOSLINK) inputs and outputs for connecting consumer electronics and professional studio equipment.
- The levels of the balanced and unbalanced outputs are adjustable so that the sensitivity of digital audio inputs can be determined.
- The format of the generated channel status data may be professional or consumer independent of the selected interface.
- A reference (XLR) and a synchronization (BNC) input provided on the rear panel allow both the analyzer and the generator to be synchronized to the digital audio reference signal (DARS according to AES 11), to wordclock, video sync signals (PAL, SECAM, NTSC) and to 1024-kHz reference clocks.
- The generator as well as the analyzer can be driven with clock rates of 27 to 55 kHz. The clock signals can also be produced internally by the generator.
- The clock rates of the analyzer and generator are independent of each other. This allows measurements on sample converters.

• The word length can be selected between 8 and 24 bits independently for generator and analyzer.



Improvement of audio quality of sound cards and multimedia equipment – a task for UPL

# Digital protocol analysis and generation (option UPL-B21)

This software option extends the functions of option UPL-B2 by an in-depth analysis and generation of additional digital data:

 Analysis of channel status and user data. The data are output in binary form, as hexadecimal numbers, as ASCII characters or, in the case of channel status data, evaluated in the professional or consumer format to AES 3 or IEC 958 (Fig. 12).

- Generation of channel status data, user data and validity bits. Channel status data can be entered in binary form or via panel to AES 3 or IEC 958 in the professional or consumer format.
- Any bits can be combined under a symbolic name. In this way, data input and representation can easily be adapted to customer's requirements.
- Simultaneous measurement of clock rate and display of interface errors (such as parity error).

# Jitter and interface tests (option UPL-B22)

With this option, the physical parameters of digital audio interfaces can be examined. UPL-B22 extends the functions of option UPL-B2.

Signal analysis:

- Measurement of jitter amplitude and display of jitter spectrum (Fig. 9).
- UPL generates bit- or word-synchronous sync signals that allow the accurate display of digital audio signals on an oscilloscope (preamble, eye pattern, signal symmetry, superimposed noise, etc).
- Measurement of input pulse amplitude and sampling frequency.
- Measurement of phase difference between audio and reference input signal.

Digital components of various data formats and clock rates are the stock-in-trade of professional users. They call for a measuring instrument offering top performance at all interfaces at high accuracy and over a wide dynamic range. Operation is identical for analog and digital interfaces, which enhances operator convenience. Fast fault diagnosis is possible by means of stored test routines, allowing the elimination of problems immediately before transmission.



- Measurement of time difference between output and input signal. This allows delay times of equalizers, audio mixers etc to be measured.
- Analysis of common-mode signal of balanced input (frequency, amplitude, spectrum).

Signal generation:

- The clock of the output signal can be "jittered" by superimposing a sinewave or noise signal of variable amplitude.
- An input signal with jitter can be output jitter-free.

- A common-mode signal can be superimposed on the balanced output signal.
- Long cables can be simulated by means of a switchable cable simulator.
- The phase shift between the digital audio and the reference output can be varied.



Test assemblies for electroacoustic converters frequently consist of microphones and loudspeakers, whose frequency response must be compensated. The equalizer function of UPL furnishes tailor-made solutions for such tests. Comprehensive test routines can be implemented with the aid of the universal sequence controller (page 13).

# Konsequent komfortabel

# Efficient online help

UPL offers a variety of help functions to provide optimum support for the user:

## **HELP** function

HELP information can be called for each input field.

## SHOW I/O key

If no results are displayed, eg because no input signal or an incorrect input signal is present, information on possible causes will appear upon pressing SHOW I/O. Moreover, the input and output configuration will be displayed.

### Info boxes

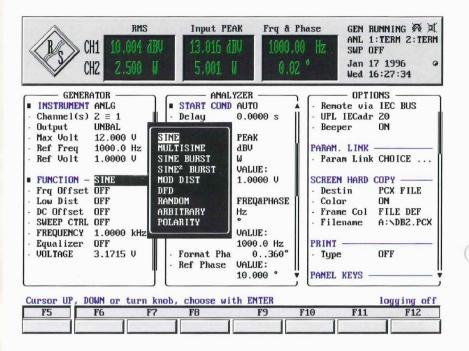
These highlighted boxes inform the user of any incorrect settings.

## **Online help**

The permissible range of values is indicated for each menu item requiring the entry of a numerical value. This range takes into account any limitations resulting from higher-order parameters, eg the sample rate in the case of measurements on digital interfaces.

## **Protection against illegal entries**

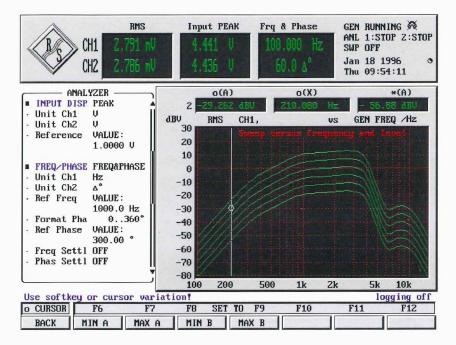
UPL will not accept entries outside the permissible range. An alarm tone will be issued, and the value changed to the permissible minimum or maximum value.

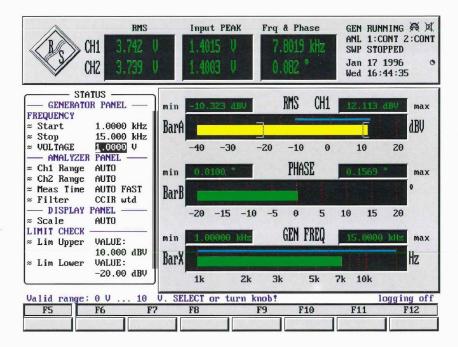


## A wealth of functions - yet easy to operate

- Related functions and settings are combined in panels that can be called at a keystroke. Up to three panels can be displayed at a time.
- The operator is not burdened with unnecessary information. Only the parameters and settings needed for a given application are displayed – the others are available in the background. For example, the sweep parameters are transferred to the generator panel and displayed only when the sweep function is activated.
- Uncomplicated entries: the user simply needs to open a menu and make entry or selection.
- Continuous status information on generator, analyzer and sweep.

- Rapid operating sequences through the use of softkeys, eg for graphical representations.
- The user can choose between operation via mouse, external keyboard or front panel. This choice makes sense since the working space required by a mouse is not always available.
- Short learning time thanks to an easy-to-understand operating concept treating analog and digital measurements in the same way.





## Results at a glance

- Real-time display of results for one or both channels and several test functions.
- Simultaneous display of frequency and phase.
- With graphics, results can be read off with vertical and horizontal cursors. Tolerance curves or stored results can be added for comparison.
- Sets of traces can be displayed, stored and evaluated for both channels.
- Graphics modes range from traces and bargraphs through spectrum display to three-dimensional waterfalls.

It is often the case that only a few parameters need to be modified after a measurement sequence has been started. Therefore, entry lines can be selected from the input panels for the generator, analyzer, etc by marking them with a tick and transferred to a status panel. The status panel thus provides a summary of parameters for a measurement routine which offers the following advantages:

- Instrument settings can be displayed together with graphical and numerical results.
- All important information can be printed on a single hardcopy.
- Instrument settings can be modified quickly without changing panels as UPL can also be operated from the status panel.

Audio Analyzer UPL is a compact unit with an integrated controller. It avoids the disadvantages of external PC control, which is found in other audio analyzers. will not be found in any conventional PC, including magnetically shielded power transformers and coated filter pane in front of the display.



The instrument is easy to transport as it requires no external equipment such as keyboard, monitor or other PC peripherals.

UPL is supplied all ready to the customer. Installation is reduced to unpacking the unit and switching it on for starting the measurement. The user can forget about problems that cropped up in the past with the installation of interface cards or PC software.

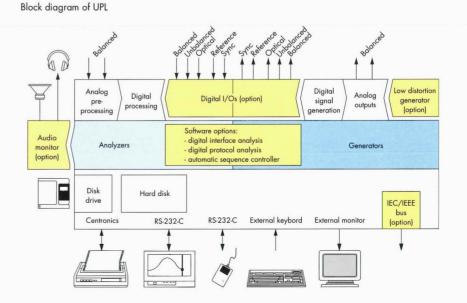
With audio analyzers controlled from an external PC, interference may be radiated from the PC, monitor or interface connections, which distorts measurement results. Not so with UPL: the instrument has specified EMC characteristics which also include the internal PC. UPL features elaborate screening which pecially in mobile use. The unit is compact and lightweight and requires no additional equipment. Results are stored in the built-in PC and thus available for later use. Routine measurements can be repeated easily using stored instrument settings.

The strengths of UPL show up es-

And a real boon: the price of UPL includes the internal PC.

# All-in package

- Built-in hard disk and disk drive.
- Connectors for keyboard, mouse, monitor, printer and plotter.
- Centronics interface for connecting printer or network.
- Drivers for all commercial printers supplied as standard.
- Remote control via IEC/IEEE bus or RS-232-C interface.
- Postprocessing of results directly in UPL using standard software.
- All results available in the common data formats, making it easy to import graphics into documents, for example.
- Easy loading of function and software extensions via floppy disk.
- Automatic test sequences and measurement programs with universal sequence controller. Easy generation of programs with built-in program generator.



# The options

## Low Distortion Generator UPL-B1

The low distortion generator is essential for all applications requiring extremely pure analog signals or an extended frequency range up to 110 kHz. Its inherent distortion is well below that of the built-in universal generator which already has excellent specifications.

## **Digital Interface UPL-B2**

contains the digital audio interfaces (balanced, unbalanced and optical). This option is described in detail on pages 8 and 9, including software extensions (protocol analysis and generation, UPL-B21, and jitter and interface test, UPL-B22).

## **Remote Control UPL-B4**

enables remote control of UPL via the RS-232-C interface or the IEC/IEEE-bus interface to IEC625/IEEE 488. The commands implemented largely correspond to SCPI guidelines.

## Audio Monitor UPL-B5

adds a headphones output and built-in loudspeaker to UPL. The input signal of the analog and digital interfaces and – with level measurements – the filtered or weighted signal can be monitored. UPL ensures high audio quality also for wireless communication

Universal Sequence Controller UPL-B10

enables measurement sequences to be generated and executed, thus turning UPL into an automatic test system. Programming of measurement sequences is greatly facilitated by the built-in program generator:

Each manual control step is recorded in the logging mode and translated into a complete line of the sequence program with correct syntax, ie test sequences can be programmed without a single line to be typed by the user. The program thus generated does not just give the sequence of keys to be pressed but contains the instructions in easy-to-read IEC/IEEE-bus syntax according to SCPI. BASIC commands can then be used to modify the program, eg for branching or graphic outputs.



Complete application programs based on the universal sequence controller are available for measurements on CD players, tuners, etc.

The universal sequence controller can also be used for remote control of external equipment via the IEC/IEEE-bus or the RS-232-C interface. On the other hand, programs generated on UPL can after slight modifications be transferred to an external controller for the remote control of UPL. This greatly facilitates the generation of remote-control programs.



High-quality voice transmission in aircraft, on ships or in trains calls for fully developed measuring techniques. Operators and manufacturers of this means of transport rely on equipment from Rohde & Schwarz for trouble-free communication. Data without tolerances are typical values

## Analog analyzers

For analog measurements two analyzers with different bandwidths, specifications and measurement functions are provided.

Andiyzer	rrequency
ANLG 22 kHz	10 Hz to
ANLG 110 kHz	20 Hz to
Level measurements (rms)	
Error limit at 1 kHz	±0.05 dB
Frequency response ref. to 1 kHz	
20 Hz to 22 kHz	±0.03 dB
10 to 20Hz	±0.1 dB
22 to 50 kHz	±0.1 dB
50 to 110 kHz	±0.2 dB

#### Inputs

#### **XLR** connectors

Voltage range Measurement range Input impedance

Crosstalk attenuation Common-mode rejection (V<sub>in</sub> <3 V)

#### Generator output

#### **Measurement functions**

 RMS value, wideband

 Error limits

 Measurement speed

 AUTO

 AUTO FAST

 Integration time

 AUTO FAST

 AUTO FAST

 AUTO VALUE

 Noise (600 Ω)

 with A filter

 with CCIR unweighting filter

Spectrum

#### RMS value, selective Bandwidth (–0.1 dB)

Selectivity

Frequency setting

Error limit

Peak value Measurement

Error limit Interval Filters fferent bandwidths, sp y range 21.90 kHz 110 kHz

2 channels, balanced (unbalanced measurements possible with XLR/BNC Adapter UPL-Z1), floating/grounded switchable 0.1  $\mu$ V to 35 V<sub>rms</sub> (sine) 18 mV to 30 V, in steps of 5 dB 100 k $\Omega$ ±1% shunted with 120 pF, each pin against ground 300  $\Omega$ , 600  $\Omega$ , ±0.5% each >120 dB, frequency <22 kHz, 600  $\Omega$  >100 dB at 50 Hz, >86 dB at 1 kHz, >80 dB at 16 kHz

each input channel switchable to the other output channel, input impedance: balanced 200 k $\Omega$ , unbalanced 100 k $\Omega$ 

 $\pm 0.05~dB$  at 1 kHz, sine  $\pm 0.1~dB$  additional error

4.2 ms, at least 1 cycle 42 ms, at least 1 cycle 1 ms to 10 s

#### 1 μV

 $<\!2$  µV, 1.6 µV typ. (ANLG 22 kHz) weighting filters and user-definable filters, up to 3 filters can be combined, analog notch filter in addition (expansion of dynamic range by up to 30 dB) post-FFT of filtered signal

1%, 3%, 1/12 octave, 1/3 octave and user-selectable fixed bandwidth, minimum bandwidth 10 Hz 100 dB (80 dB) with analyzer ANLG 22 kHz (110 kHz), bandpass or bandstop filter, 8th-order elliptical filter, analog notch filter in addition – automatic to input signal – coupled to generator – fixed through entered value – sweep through selectable range ±0.2 dB + ripple of filters with analyzer ANLG 22 kHz only peak max., peak min., peak-to-peak, peak absolute ±0.2 dB at 1 kHz 20 ms to 10 s

weighting filters and user-definable filters, up to 3 filters can be combined

**Quasi-peak** Measurement, error limits Noise (600 Ω) Filters

#### **DC voltage** Voltage range Error limit

Measurement range

S/N measurement routine
FFT analysis
Total harmonic distortion (THD)
Fundamental

Frequency tuning Weighted harmonics

Error limits harmonics <50 kHz ±0.5 dB <110 kHz ±0.7 dB Inherent distortion \*) Analyzer ANLG 22 kHz Fundamental 20 Hz to 10.95 kHz <-110 dB, typ. -115 dB 10 to 20 Hz <-100 dB

Anatyzer ANLG 110 kHz Fundamental 50 Hz to 20 kHz <-100 dB, typ. –105 dB Spectrum bar chart showing signal and distortion

 \*) Total inherent distortion of analyzer and generator (with option UPLB1), analyzer with dynamic mode precision.
 >3.5 V: typ. reduced by 3 dB; <0.5 V: sensitivity reduced by input noise (typ. 0.25/1.25 μV for analyzers 22/110 kHz).

with analyzer ANLG 22 kHz only to CCIR 468-4

<8 µV with CCIR weighting filter,

100 mV to 30 V, in steps of 10 dB

available for measurement functions

indication of S/N ratio in dB, no post-FFT

see FFT analyzer section

automatic to input signal
fixed through entered value

any combination of  $d_2$  to  $d_9$ ,

analog notch filter in addition

0 to ±35 V

 $\pm(1\% + 2 \text{ mV})$ 

– rms, wideband – peak – quasi-peak

10 Hz to 22 kHz

up to 110 kHz

weighting filters and user-definable filters, up to 3 filters can be combined,

### THD+N and SINAD

Fundamental 20 Hz to 22 kHz Frequency tuning - automatic to input signal - fixed through entered value  $>100 \ \mu V$  typ. with automatic tuning upper and lower frequency limit se-Input voltage Bandwidth lectable, one weighting filter in addition Error limits Bandwidth <50 kHz ±0.5 dB <100 kHz ±0.7 dB Inherent distortion \*) Analyzer ANLG 22 kHz Bandwidth 20 Hz to 21.90 kHz typ. –110 dB at 1 kHz, 2.5 V <–105 dB +2 μV \*\*) typ. -108 dB +1.5 µV Analyzer ANLG 110 kHz Bandwidth 128 Hz to 22 kHz  $<-95 \text{ dB} + 2.5 \text{ }\mu\text{V}$ typ. -100 dB +1.75 μV 128 Hz to 110 kHz  $\,$  <-88 dB + 5  $\mu V$ typ. -95 dB + 3.5 μV

#### Spectrum

\*) Total inherent distortion of analyzer and generator (with option UPL-B1), analyzer with dynamic mode precision.

\*\*) For full measurement range (<-100 dB + 2  $\mu V$  with auto range function). <-100 dB for input voltage >3.5 V.

post-FFT of filtered signal

#### Modulation factor (MOD DIST)

Measurement method		selective to DIN IEC 268-3			
Frequency range, low	ver frequency	30 to 500 Hz			
up	per frequency	4 to 100 kHz*)			
Error limit		±0.50 dB			
Inherent distortion * *)					
Upper frequency	4 to 15 kHz	<-96 dB (-90 dB), typ103 dB			
11 1 7		<-96 dB (-85 dB)			
Spectrum		bar chart showing signal and distortion			

\*) For upper frequency >20 kHz the bottom limit of lower frequency is reduced. \*\*) Input voltage >200 mV, typical values apply to 0.5 to 3.5 V. Lower frequency >200 Hz, values in () for lower frequency <200 Hz. Dynamic mode precision; level ratio LF:UF = 4:1.

#### Difference frequency distortion (DFD) Signals selective to DIN IEC 268-3 Measurement method Sine Frequency range 2 Hz to 21.75 kHz Frequency range difference frequency 80 Hz to 2 kHz center frequency ±50 ppm ±0.1 dB at1 kHz 200 Hz to 100 kHz\*) Frequency error Error limit ±0.50 dB, center frequency <20 kHz level error Frequency response (referred to 1 kHz) 20 Hz to 20 kHz <-112 dB, typ. -125 dB Inherent distortion \*\*) DFD d<sub>2</sub> <-96 dB, typ. –105 dB bar chart showing signal and distortion +0.05 dB DFD d2 Inherent distortion THD+N Spectrum Measurement bandwidth \*) For center frequency >20 kHz the bottom limit of the difference frequency 20 Hz to 22 kHz <-94 dB, typ. -98 dB 20 Hz to 100 kHz is reduced <-86 dB \*\*) Input voltage >200 mV, typical values apply to 0.5 to 3.5 V, Sweep parameters frequency, level dynamic mode precision (at DFD $d_2$ ), center frequency 7 to 20 kHz. Sine (with low-distortion generator option) Wow and flutter 10 Hz to 110 kHz with analyzer ANLG 22 kHz only Frequency range Measurement method DIN/IEC, NAB, JIS, Frequency error ±0.5% at 15 to 30°C 2-sigma to IEC-386 ±0.75% at 5 to 45°C Weighting filter OFF highpass 0.5 Hz, bandwidth 200 Hz Level error ±0.1 dB at 1 kHz ON bandpass 4 Hz to IEC-386 Frequency response (ref. to 1 kHz) ±3% Error limit 20 Hz to 20 kHz ±0.05 dB <0.0005% weighted Inherent noise 10 Hz to 110 kHz +0 1 dB <0.001% unweighted typ. <-115 dB (<-120 dB at 1 kHz), Harmonics Spectrum post-FFT of demodulated signal measurement bandwidth 20 Hz to 20 kHz, voltage 1 to 5 V Time domain display (WAVEFORM) Inherent distortion (THD) rising/falling edge -50 to +50 V, interpolated between Trigger Fundamental 1 kHz, 1 to 10 V <-115 dB typ. <-105 dB Trigger level 20 Hz to 7 kHz samples max. 7424 points 7 to 20 kHz <-100 dB Trace length Standard mode 1- to 32-fold interpolation Inherent distortion (THD+N) \*) Fundamental 1 kHz, 2.5 V Compressed mode 2- to 1024-fold compression -110 dB typ. (envelope for AGC measurement), with 20 Hz to 20 kHz <-100 dB +2 µV 22 kHz analyzer ANLG 22 kHz only 20 Hz to 20 kHz <-88 dB +5 µV Sweep parameters frequency, level Frequency \*) Frequency range 20 Hz to 110 kHz \*) Total inherent distortion of analyzer and generator, Error limit ±50 ppm analyzer with dynamic mode precision. with analyzer 22 kHz only 20 Hz to 20 kHz ±0.5° Phase \*) for measuring the modulation distortion MOD DIST Frequency range Error limit Frequency range, lower frequency 30 to 500 Hz 4 to 21.75 kHz upper frequency from 10:1 to 1:1, selectable Level ratio (LF:UF) with analyzer 22 kHz only Group delay\*) level error ±0.5 dB Frequency range Measurement error in seconds 20 Hz to 20 kHz Inherent distortion <-94 dB (typ. –100 dB) at 7 kHz, 60 Hz $\Delta \phi / (\Delta f \cdot 360) **)$ <-84 dB (typ. -90 dB), level ratio LF:UF = 4:1 \*) Only for measurement functions RMS, FFT and THD+N, error limits apply Sweep parameters upper frequency, level to 8k FFT with zoom factor 2, Rife-Vincent-2 window; S/N ratio >70 dB. \*\*) $\Delta \phi$ = phase measurement error in °, $\Delta f$ = frequency step. DFD for measuring the difference tone Frequency range, difference frequency 80 Hz to 2 kHz Polarity test 200 Hz to 20.75 kHz center frequency Measurement polarity of unsymmetrical input signal Level error ±0.5 dB Display +POL, -POL DFD d<sub>2</sub> <-114 dB, typ.-120 dB Inherent distortion\*) <-92 dB, typ. -100 dB DFD d<sub>3</sub> Sweep parameters center frequency, level **Analog** generators \*) Center frequency >5 kHz, difference frequency <1 kHz; DFD d<sub>2</sub> -100 dB (typ.) with DC offset. An 18-bit $\Delta\Sigma$ D/A converter is used for analog signal generation. The charac-**Multi-sine** teristics of the basic generator can be improved and extended with a low-dis-2.93 Hz to 21.75 kHz Frequency range tortion RC oscillator (Low Distortion Generator UPL-B1): adjustable from 2.93 Hz Frequency spacing - sine with reduced distortion Frequency resolution <0.01% or matching FFT frequency - frequency range up to 110 kHz spacing 100 dB, referred to total peak value Dynamic range Outputs Characteristics 1 to 17 spectral lines Mode 1 XLR connectors, 2 channels, floating, balanced/unbalanced switchable, - level and frequency selectable for short-circuit-proof; max. current <120 mA with external feed each line phase of each component optimized Balanced $\begin{array}{l} 0.1 \text{ mV to } 20 \text{ V}_{rms} \text{ (sine, open-circuit)} \\ > 115 \text{ dB, frequency } < 20 \text{ kHz} \\ < 10 \,\Omega, 200 \,\Omega \pm 0.5\%, \, 600 \,\Omega \pm 0.5\% \end{array}$ for minimum crest factor Voltage Crosstalk attenuation - rms and peak value of total signal Source impedance displayed Load impedance >400 $\Omega$ (incl. source impedance) Mode 2 1 to 7400 spectral lines (noise in frequency domain), distribution: white, Output balance >75 dB at 1 kHz. pink, 1/3 octave, defined by file >60 dB at 20 kHz Unbalanced Sine burst, sine<sup>2</sup> burst 1 sample up to 60 s, 1-sample resolution burst time up to 60 s, 1-sample resolution 0.1 mV to 10 V<sub>rms</sub> (sine, open-circuit) Voltage Burst time Crosstalk attenuation >115 dB, frequency <20 kHz Interval O to burst level, absolute or relative to Low level Source impedance 50 burst level (0 with sine<sup>2</sup> burst) >200 Ω Load impedance 21.75 kHz (elliptical filter) Bandwidth Sweep parameters burst frequency, level, time, interval

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Meas. bandw.

22 kHz

100 kHz

#### Noise Distribution

Arbitrary waveform Memory size Clock rate Bandwidth

Polarity test signal

Sine<sup>2</sup> burst with following characteristics: Frequency On-time Interval

DC offset\*) Error

**Residual** offset

\*) No DC offset for signal generation with Low Dist ON. With DC offset the AC voltage swing will be reduced; specified inherent distortion values apply to DC offset = 0.

# Digital analyzer (with option UPL-B2)

Frequency limits specified for measurement functions apply to a sampling rate of 48 kHz. For other sampling rates limits are calculated according to the formula:  $f_{new} = f_{48 \text{ kHz}} \cdot \text{sampling rate}/48 \text{ kHz}.$ 

### Inputs

Balanced input Impedance Level (V<sub>pp</sub>) Unbalanced input Impedance Level (V<sub>pp</sub>) Optical input Channels Audio bits Clock rate Format

XLR connector, transformer coupling 110Ω min. 200 mV, max. 12 V BNC, grounded **75**Ω min. 100 mV, max. 5 V TOSLINK 1, 2, or both 8 to 24 27 to 55 kHz professional and consumer format to IEC-958 as well as user-definable formats at all inputs

up to 0.5 times the clock rate

4.2 ms, at least 1 cycle

42 ms, at least 1 cycle

post-FFT of filtered signal

min. bandwidth 10 Hz

8th-order elliptical filter

- automatic to input signal

- fixed through entered value

sweep through selectable range

peak max., peak min., peak-to-peak,

weighting filters and user-definable fil-

ters, up to 3 filters can be combined

coupled to generator

 $\pm 0.2 \text{ dB} + \text{ripple of filters}$ 

peak absolute

20 ms to 10 s

±0.2 dB at 1 kHz

weighting filters and user-definable fil-

ters, up to 3 filters can be combined

1%, 3%, 1/12 octave, 1/3 octave

and user-selectable fixed bandwidth,

100 dB, bandpass or bandstop filter,

±0.1 dB

+0.01 dB

±0.001 dB

1 ms to 10 s

### **Measurement functions**

(all measurements at 24 bits, full scale)

## RMS value, wideband

Measurement bandwidth Error limits AUTO FAST AUTO FIX Integration time AUTO FAST AUTO VALUE Filters

Spectrum

RMS value, selective Bandwidth (-0.1 dB)

Selectivity

Frequency setting

Error limit

Peak value Measurement

Error limit Interval Filters

Gaussian, triangular, rectangular

1.2 kHz 1 cycle (0.8333 ms) 2 cycles (1.6667 ms)

0 to ±10.0 V (±5 V unbalanced) ±2% <1% of rms value of AC signal

Quasi-peak Measurement, error limits Filters

DC voltage Measurement range Error limit

## S/N measurement routine

FFT analysis

Total harmonic distortion (THD) Fundamental Frequency tuning

Weighted harmonics

Error limit Inherent distortion <sup>1</sup>) Fundamental 42 Hz to 21.90 kHz <-130 dB 24 to 42 Hz 12 to 24 Hz Spectrum

### THD+N and SINAD

Fundamental Frequency tuning

Stopband range

Bandwidth

Error limit Inherent distortion<sup>1</sup>) Bandwidth 20 Hz to 21.90 kHz Fundamental 28 Hz to 21.90 kHz <-126 dB 24 to 28 Hz 20 to 24 Hz Spectrum

# Modulation distortion (MOD DIST)

Measurement method Frequency range Lower frequency Upper frequency Error limit Inherent distortion<sup>1</sup> Level LF:UF 1.1 4.1 10:1

Spectrum

Difference frequency distortion (DFD)

Measurement method Frequency range Difference frequency Center frequency Error limit Inherent distortion<sup>1</sup>) DFD d<sub>2</sub> DFD d<sub>3</sub> Spectrum Wow and flutter

Measurement method

Weighting filter OFF ON Error limit Inherent noise

Spectrum

bandpass 4 Hz to IEC-386 ±3% <0.0003% weighted <0.0008% unweighted post-FFT of demodulated signal

1) Total inherent distortion of analyzer and generator.

<sup>2</sup>) Fixed frequency independent of sampling rate.

## ±1% available for measurement functions: - rms, wideband - peak – quasi-peak indication of S/N ratio in dB, no post-FFT

to CCIR 468-4

0 to  $\pm$ FS

weighting filters and user-definable fil-

ters, up to 3 filters can be combined

see FFT analyzer section

10 Hz to 21.90 kHz - automatic to input signal - fixed through entered value any combination of  $d_2$  to  $d_9$ up to 21.90 kHz ±0.1 dB

<-112 dB <-88 dB bar chart showing signal and distortion

20 Hz to 21.90 kHz - automatic to input signal - fixed through entered value fundamental ±28 Hz, max. up to 2nd harmonic upper and lower frequency limit selectable, one weighting filter in addition ±0.3 dB

<-109 dB <-96 dB post-FFT of filtered signal

selective to DIN-IEC 268-3

30 to 500 Hz<sup>2</sup>) 42) to 21.25 kHz  $+0.2 \, dB$ 

<-133 dB <-123 dB <-115 dB

bar chart showing signal and distortion

selective to DIN IEC 268-3

80 Hz to 2 kHz<sup>2</sup>) 200 Hz to 20.90 kHz ±0.2 dB <-130 dB <-130 dB bar chart showing signal and distortion

DIN/IEC, NAB, JIS, 2-sigma to IEC-386 highpass 0.5 Hz, bandwidth 200 Hz

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loaded from file max. 16 k 48 kHz 21.75 kHz (elliptical filter) Time domain display (WAVEFORM) Trigger Trigger level

Trace length Standard mode Compressed mode

Frequency \*) Frequency range Error limit

Phase \*) Frequency range Error limit

### Group delay\*) Frequency range

Measurement error in seconds  $\Delta \phi / (\Delta f \cdot 360) * *)$ 

Only for measurement functions RMS, FFT and THD+N, \*) error limits apply to 8k FFT with zoom factor 2, Rife-Vincent-2 window; S/N ratio >70 dB.

\*\*)  $\Delta \varphi$  = phase measurement error in °,  $\Delta f$  = frequency step.

### **Polarity test**

Measurement Display

polarity of unsymmetrical input signal +POL -POL

max. 7424 points

20 Hz to 20 kHz

20 Hz to 20 kHz

20 Hz to 20 kHz

±50 ppm

+0.5

1- to 32-fold interpolation

2- to 1024-fold compression

(envelope for AGC measurement)

## Digital generator (with option UPL-B2)

Frequency limits specified for the signals apply to a sampling rate of 48 kHz. For other sampling rates limits are calculated according to the formula:  $f_{new} = f_{48 \text{ kHz}} \cdot \text{sampling rate}/48 \text{ kHz}.$ 

2-24

2-24 FS to 1 FS

0 or +1000 ppm

0 to  $\pm 1$  FS adjustable

2 Hz<sup>2</sup>) to 21.90 kHz

<–133 dB

frequency, level

30 to 500 Hz<sup>2</sup>)

42) to 21.90 kHz

#### Outputs

**Balanced** output Impedance Level (V<sub>pp</sub> into 110 Ω) Error limit Unbalanced output Impedance Level ( $V_{pp}$  into 75  $\Omega$ ) Error limit Optical output Channels Audio bits Clock rate

Format

#### Signals

(all signals with 24 bits, full scale)

#### General characteristics

Level resolution Audio bits Dither\*) Distribution Level Frequency error

Frequency offset\*) DC offset

\*) With sine, DFD and MOD DIST signals.

#### Sine

Frequency range Total harmonic distortion (THD) Sweep parameters

#### MOD DIST

Frequency range Lower frequency Upper frequency

0 to 8 V, in 240 steps ±1 dB<sub>rms</sub> BNC, transformer coupling 75 Ω, short-circuit-proof 0 to 2 V, in 240 steps ±1 dB<sub>rms</sub> TOSLINK 1, 2, or both 8 to 24 internal: 27 to 55 kHz or synchronization to analyzer external: synchronization to wordclock input, video sync, DARS, 1024 kHz professional and consumer format to IEC-958 as well as user-definable formats at all outputs

8 to 24 bits, LSB rounded off

±50 ppm (internal clock),

±1 ppm relative to clock rate

Gaussian, triangular, rectangular

for measuring the modulation distortion

XLR connector, transformer coupling

110Ω, short-circuit-proof

Level ratio (LF:UF) Inherent distortion<sup>1</sup>) Level LF:UF 1:1 Sweep parameters

## DFD

Frequency range Difference frequency Center frequency Inherent distortion DFD d<sub>2</sub> DFD da Sweep parameters

1.1

10:1

#### **Multi-sine**

Frequency range Frequency spacing Frequency resolution

Dynamic range Characteristics Mode 1

Mode 2

#### Sine burst, sine<sup>2</sup> burst **Burst time** Interval Low level

Sweep parameters

Noise Distribution

Arbitrary waveform Memory size

Polarity test signal Sine<sup>2</sup> burst with the following Frequency On-time Interval

# Digital audio protocol (option UPL-B21)

#### Generator Validity bit

Channel status data

User data

Analyzer Display

Error indication

Clock rate measurement Channel status display

User-bit display

from 10:1 to 1:1, selectable <-133 dB

<-123 dB <-115 dB upper frequency, level

for measuring the difference tone

80 Hz to 2 kHz<sup>2</sup>) 200 Hz<sup>2</sup>) to 20.90 kHz

<-130 dB <-130 dB center frequency, level

2.93 Hz to 21.90 kHz adjustable from 2.93 Hz <0.01% or matching FFT frequency spacing >133 dB FS

1 to 17 spectral lines – level and frequency selectable

- for each line - phase of each component
- optimized for minimum crest factor
- rms and peak value of total signal

displayed 1 to 7400 spectral lines (noise in frequency domain), distribution: white, pink, 1/3 octave, defined by file

1 sample up to 60 s, 1-sample resolution burst time up to 60 s, 1-sample resolution O to burst level, absolute or referred to burst level (O for sine<sup>2</sup> burst) burst frequency, level, time, interval

Gaussian, triangular, rectangular

loaded from file max. 16k sampling rate of generator

1.2 kHz<sup>2</sup>) 1 cycle 2 cycles

to zero

NONE, L, R, L+R mnemonic entry with user-definable masks, predefined masks for professional and consumer format to IEC 958

loaded from file (max. 384 bits) or set

- validity bit L and R - change of status bits differences between L and R block errors, sequence errors, clock rate errors, preamble errors 50 ppm user-definable mnemonic display of data fields, predefined settings for professional and consumer format to IEC 958, binary and hexadecimal format user-definable mnemonic display, block-synchronized

1) Total inherent distortion of analyzer and generator.

<sup>2)</sup> Fixed frequency independent of sampling rate.

Clock rate

characteristics:

## rising/falling edge -1 FS to +1 FS, interpolated between samples

# Jitter and interface test (option UPL-B22)

sine, noise

sine

0 to 20 V

0 to 10 V

27 to 55 kHz

on balanced input

20 Hz to 110 kHz

100 µs to 500 ms

-64 to +64 UI

0 to 30 V

>135 dB

notch filter)

log notch filter)

Kaiser ( $\beta = 1$  to 20) from 0.05 Hz with zoom,

from 5.86 Hz without zoom 2 to 128 (2 to 8)

notch filter)

-160 dB

with option UPL-B1)

for balanced output

10 Hz to 21.75 kHz (sine to 110 kHz

0 to 5 UI (corresp. to 0 to 800 ns at 48 kHz sampling rate)

20 Hz to 21.75 kHz (110 kHz with option UPL-B1)

adjustable between -64 and +64 UI (corresp. to  $\pm 50\%$  of frame)

amplitude, frequency, spectrum 0 to 5 UI typ. for f <500 Hz, decreasing

input signal is sampled with a low-jitter

clock signal and available at reference

output (XLR connector on the rear)

100 m typical audio cable

to 0.5 UI for f up to 50 kHz

(corresp. to ±50% of frame)

10 Hz to 21.90 kHz (110 kHz)

120 dB/105 dB (with/without analog notch filter) 115 dB/85 dB (with/without analog

-140 dB/110 dB (with/without ana-

-120 dB/90 dB (with/without analog

256, 512, 1 k, 2 k, 4 k, 8 k points (16 k with zoom factor 2)

1 to 256, exponential and normal

rectangular, Hann, Blackman-Harris, Rife-Vincent 1 to 3, Hamming, flat top,

200 ps (noise floor with 8k FFT)

Generator

Jitter injection Signal shape Frequency range

Amplitude (peak-to-peak)

Common mode signal Waveform Frequency range

Amplitude (V<sub>pp</sub>) Phase (output to reference)

Cable simulator

Analyzer Input signal Amplitude (V<sub>pp</sub>) Sampling rate Jitter measurement

Measurement limit Reclocking

Common mode test Amplitude (V<sub>pp</sub>) Frequency, spectrum Phase (input to reference)

Delay (input to output)

# FFT analyzer

Specifications apply to analyzer ANLG 22 kHz or digital analyzer; values in ( ) apply to analyzer ANLG 110 kHz.

Frequency range
Dynamic range
Digital
ANLG 22 kHz
AINLO 22 KITZ

ANLG 110 kHz

Noise floor Digital ANLG 22 kHz

ANLG 110 kHz

FFT size

Window functions

Resolution Zoom

Averaging

# Filters

For all analog and digital analyzers. Up to 3 filters can be combined as required. All filters are digital filters with a coefficient accuracy of 32 bit floating point (exception: analog notch filter).

### Weighting filters

- A weighting – C message
- CCITT
- CCIR weighted, unweighted
- CCIR ARM
- deemphasis 50/15, 50, 75, J.17
- rumble weighted, unweighted
- DC noise highpass filter

## User-definable filters

Design parameters:

sth-order elliptical, type C, passband ripple +0/-0.1 dB, stopband attenuation approx. 20 to 120 dB selectable in steps of approx. 10 dB (highpass and lowpass filters: stopband attenuation 40 to 120 dB).

Highpass, lowpass filters	limit frequencies (–0.1 dB) selectable, stopband indicated
Bandpass, bandstop filters	passband (–0.1 dB) selectable, stopband indicated
Notch filter	center frequency and width (–0.1 dB) selectable, stopband indicated
One-third and octave filters	center frequency selectable, bandwidth (–0.1 dB) indicated
File-defined filters	any 8th-order filter cascaded from 4 bi- quads, defined in the z plane by poles/zeroes or coefficients

### Analog notch filter

For measurements on signals with high S/N ratio, this filter improves the dynamic range of the analyzer by up to 30 dB to 140 dB for analyzer 22 kHz, or 120 dB for analyzer 110 kHz (typical noise floor of FFT). The filter is also used for measuring THD, THD+N and MOD DIST with dynamic mode precision.

available in analog analyzers

10 Hz to 22.5 kHz center frequency (f<sub>c</sub>)

- fixed through entered value typ. >30 dB,  $f_c \pm 0.5\%$ typ. -3 dB at 0.77  $\cdot$   $f_c$  and 1.3  $\cdot$   $f_c$ ,

typ. +0/-1 dB outside 0.5 · fc to 2 · fc

with measurement functions:

- automatic to input signal

- coupled to generator

– rms, wideband

- rms, selective

quasi-peak

– FFT analysis

Characteristics

Frequency range Frequency tuning

Stopband range Passband range

# Audio monitor (option UPL-B5)

Headphone connector	6.3-mm jack socket
Output voltage	max. 8 V <sub>p</sub>
Output current	max. 50 mAn
Source impedance	10 Ω, short-circuit-proof
Recommended headphone impedance	

## Sweep

frequency, level, with bursts also interval and duration, one or two-dimensional	
linear, logarithmic, tabular,	
single, continuous, manual – automatic after end of measurement – time delay (fixed or loaded table)	
frequency or level of input signal	
single, continuous	
<ul> <li>delayed (0 to 10 s) after input level or input frequency variation, settling function selectable</li> <li>time-controlled</li> </ul>	
for level, frequency, phase, distortion measurements, settling function: exponential, flat or averaging	

### Sweep speed

AUTO

Two-channel rms measurement 20 Hz to 20 kHz, 30-point generator sweep, logarithmic (frequency measurement and input display switched off, Low Dist off, UPL 05). with AUTO FAST 1 s

2.5 s

# Display of results

 $\bigcirc$ 

<b>Units</b> Level (analog)	V, dBu, dBV, W, dBm, difference (∆), deviation (∆%) and ratio (without dimension, %, dBr), to reference value	Operating temperature range Storage temperature range Humidity EMI	0 to +45°C -20 to +60°C max. 85% for ma below 65% on av no condensation EN 50081-1	
Level (digital)	FS, %FS, dBFS, LSBs deviation (∆%) or ratio (dBr), to reference value	EMI EMS Power supply Dimensions (W x H x D)	EN 50082-1 100/120/220/2 50 to 60 Hz, 110	
Distortion	% or dB, referred to signal amplitude, THD and THD+N in all available level units (absolute or relative to selectable reference value)	Weight	12.6 kg	m x 47 5 mm
Frequency	Hz, difference (Δ), deviation (Δ%) and ratio (as quotient f/f <sub>ref</sub> , 1/3 octave, octave or decade), to reference value (entered or stored, current generator frequency)	Ordering information		
Phase Reference value (level): Fixed value (entered or stored).	°, rad, difference (Δ), to reference value (entered or stored)	Order designation Audio Analyzer UPL Monochrome LCD, CPU 386 Colour LCD, CPU 486		1078.2008.02 1078.2008.05
Current value of a channel or generate gain, linearity, channel difference, crc trace or loaded from file) can be used		Accessories supplied	system and user n	erating manual, MS-DOS operating nanual, backup pro- erating and measure-
Graphical display of results Monitor	9", LCD, monochrome or colour	Options		
Display modes Display functions	<ul> <li>display of any sweep</li> <li>display of trace groups</li> <li>bargraph display with min./max. values</li> <li>spectrum, also as waterfall display</li> <li>lists of results</li> <li>bar charts for THD and intermodula- tion measurements</li> <li>autoscale</li> <li>X-axis zoom</li> <li>full-screen and part-screen mode</li> </ul>	Low Distortion Generator Digital Audio I/O Digital Audio Protocol Jitter and Interface Test Remote Control Audio Monitor Universal Sequence Controller XLR/BNC Adapter Set	UPL-B1 UPL-B2 UPL-B21 UPL-B22 UPL-B4 UPL-B5 UPL-B10 UPL-Z1	1078.4400.02 1078.4000.02 1078.3956.02 1078.3956.02 1078.3804.02 1078.4600.02 1078.3904.02 1078.3704.02
	<ul> <li>- 2 vertical, 1 horizontal cursor line</li> <li>- 2 vertical, 1 horizontal cursor line</li> <li>- search function for max. values</li> <li>- marker for harmonics (spectrum)</li> <li>- user-labelling for graphs</li> <li>- change of unit and scale also possible for loaded traces</li> </ul>	<b>Recommended extras</b> 19" Rack Adapter Service manual	ZZA-95	0396.4911.00 1078.2089.24
Test reports Functions	<ul> <li>screen copy to printer, plotter or file (PCX and HPGL format)</li> <li>lists of results</li> <li>sweep lists</li> <li>tolerance curves</li> <li>list of out-of-tolerance values</li> <li>equalizer traces</li> </ul>			
Printer driver Plotter language Interfaces	supplied for approx. 130 printers HP GL 2 x RS-232-C, Centronics, IEC 625 (option UPL-B4)			
Storage functions	– instrument settings – spectra – sweep results – sweep lists – tolerance curves – equalizer traces			
Remote control	via IEC 625-2 (IEEE 488) and RS-232-C; commands largely to SCPI (option UPL-B4)			

General data



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